

K-No.: 26622

300mA Differential Current Sensor for 5V Supply Voltage

For the electronic measurement of current:
DC, AC, pulsed, with galvanic isolation between the primary and the secondary circuit



Date: 28.06.2021

Customer: Standard type

Customers Part no:

Page 1 of 4

Description

- Closed loop (compensation) Current Sensor with magnetic probe
- Printed circuit board mounting
- Casing and materials UL-listed

Characteristics

- excellent accuracy
- very low offset current
- very low temperature dependency and offset drift
- very low hysteresis of offset current
- short response time
- wide frequency bandwidth
- compact design
- reduced offset ripple

Applications

Mainly used for stationary operation in industrial applications:

- Solar inverter

Electrical data - Ratings

I_{PN}	Primary nominal RMS current	50	A
$I_{\Delta N}$	Differential rated RMS current	0.3	A
V_{OUT}	Output voltage @ $I_{\Delta P}$	$V_{REF} \pm (0.74 * I_{\Delta P} / I_{\Delta N})$	V
$V_{OUT(0)}^1$	Output voltage @ $I_P=0A, \vartheta_A=25^\circ C$	$V_{REF} \pm 0.025$	V
$V_{OUT(Error)}$	in case of error (current sensor) $V_{OUT} < 0.5V$ is set	< 0.5	V
V_{REF}	internal reference voltage	2.5 ± 0.005	V
	external reference voltage range	1.4 ... 3.5	V
$V_{REF(test\ current)}^2$	Reference voltage (external)	0 ... 0.1	V
$V_{OUT(test\ current)}^2$	Output voltage @ $V_{REF} = 0 \dots 0.1V$	$V_{OUT(0)} + 0.25 \pm 0.06$	V
K_N	Transformation ratio	1:1:1:1 : 20 : 1000	

¹ with switching on and after "test current" the sensor is degaussed by an internal AC-current for about 110ms. In this time the output is set to $V_{OUT} < 0.5V$.

² If V_{REF} is set external to 0...0.1V an internal test current is generated.

Accuracy – Dynamic performance data

		min.	typ.	max.	Unit
$I_{\Delta P,max}$	Max. measuring range (differential current)	± 0.85			A
X	Accuracy @ $I_{\Delta N}, \vartheta_A = 25^\circ C$			± 1.5	%
ϵ_L	Linearity			± 1	%
$V_O (V_{OUT}-V_{REF})$	Offset voltage @ $I_P = 0A, \vartheta_A = 25^\circ C$			± 25	mV
$\Delta V_O/\Delta T$	Temperature drift of V_{OUT} @ $I_P=0A, \vartheta_A$		0.1		mV/°C
t_r	Response time @ 90% of $I_{\Delta N}$		35		μs
f_{BW}	Frequency bandwidth	DC...8			kHz

General data

ϑ_A	Ambient operation temperature	-40		85	°C
ϑ_S	Ambient storage temperature (acc. to M3101)	-40		85	°C
m	Mass		75		g
V_C	Supply voltage	4.75	5	5.25	V
I_C	Supply current at $I_P = 0A$ and RT		15		mA

¹ S_{clear}	Clearance (component without solder pad)	8.5			mm
¹ S_{creep}	Creepage (component without solder pad)	10.0			mm
¹ U_{sys}	System voltage *determines impulse voltage acc. table 7			600	V_{RMS}
¹ U_{AC}	Working voltage *acc. table 10			1000	V_{RMS}
¹ U_{PD}	Rated discharge voltage *acc. table 24 with $U_{PD}=U_{AC}*\sqrt{2}$			1414	V_{PEAK}

¹Constructed and manufactured and tested in accordance with IEC 61800-5-1:2007

Reinforced Insulation, Pollution degree 2, Overvoltage category III, Insulation material group I

Date	Name	Issue	Amendment
28.06.2021	DJ	81	Further standards: UL 508, file E317483, category NMTR2 / NMTR8. And add UL sign to mechanical dimension and marking info box in datasheet. CN-21-223

Hrg.: R&D-PD NPI D editor	Bearb.: DJ designer	MC-PM: NSch. check	freig.: SB released
---------------------------	---------------------	--------------------	---------------------

K-No.: 26622

300mA Differential Current Sensor for 5V Supply Voltage

For the electronic measurement of current:
DC, AC, pulsed, with galvanic isolation between the primary and the secondary circuit



Date: 28.06.2021

Customer: Standard type

Customers Part no:

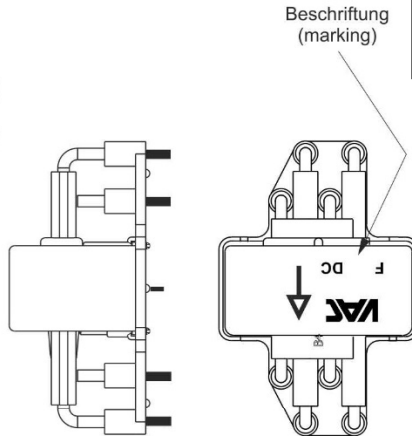
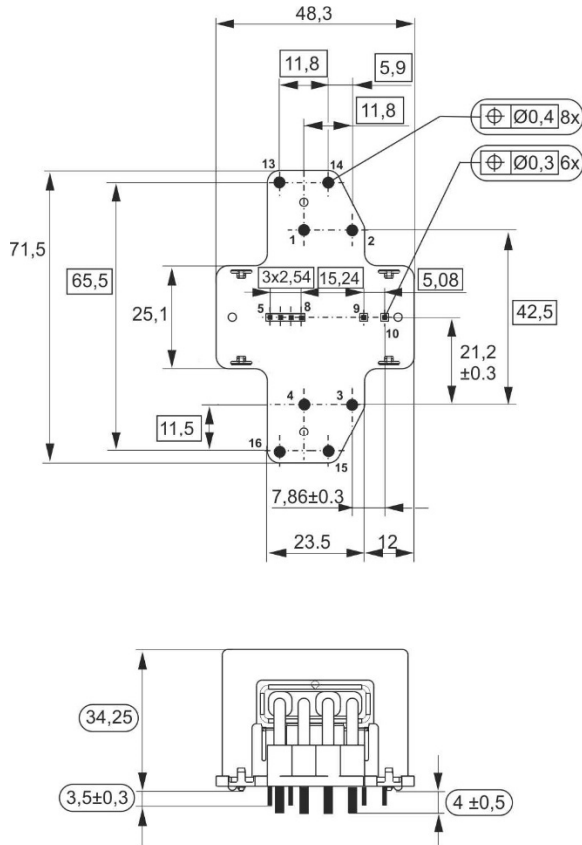
Page 2 of 4

Mechanical outline (mm):

General tolerances DIN ISO 2768-c

Connections:

Pin 5-10: 0.7mm x 0.7mm
Pin 1-4, 13-16: Ø2.8mm



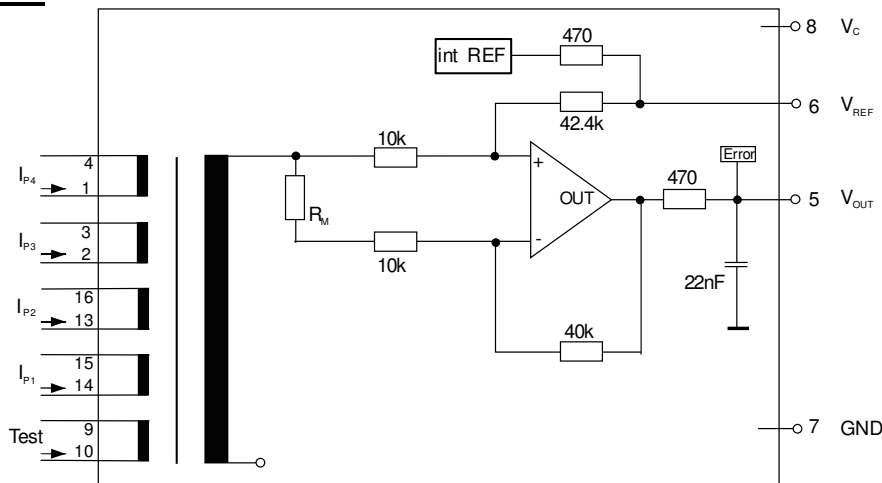
Marking:

VAC
UL-sign
4646-X932
F DC

○ = Prüfmaß (test dimension)

DC = Date Code
F = Factory

Schematic diagram:



Hrg.: R&D-PD NPI D editor

Bearb.: DJ designer

MC-PM: NSch. check

freig.: SB released

K-No.: 26622

300mA Differential Current Sensor for 5V Supply Voltage

For the electronic measurement of current:
DC, AC, pulsed, with galvanic isolation between the primary and the secondary circuit



Date: 28.06.2021

Customer: Standard type

Customers Part no:

Page 3 of 4

Electrical data: (investigate by a type checking)		min.	typ.	max.	Unit
$V_{C,max}$	maximum supply voltage (without function)			6	V
I_c	Supply current with primary current	$15mA + I_{\Delta P} \cdot K_N + V_{OUT}/R_L$			mA
$I_{OUT,SC}$	Short circuit output current		± 10		mA
R_s	Secondary coil resistance @ $\theta_A = 85^\circ C$			80	Ω
R_{Test}	Test winding resistance @ $\theta_A = 25^\circ C$		0.9		Ω
$R_{P1,P2}$	Primary wire resistance @ $\theta_A = 25^\circ C$		0.24		m Ω
$R_{i,REF}$	Internal resistance of reference input		470		Ω
$R_{i,OUT}$	Output resistance of V_{OUT}		470		Ω
$\Delta X_\theta/\Delta\theta$	Temperature drift of X @ $\vartheta_A = -40^\circ C \dots 85^\circ C$			400	ppm/K
$\Delta V_{REF}/\Delta\theta$	Temperature drift of V_{REF} @ $\vartheta_A = -40^\circ C \dots 85^\circ C$		5	50	ppm/K
$\Delta V_{O=}$ $\Delta(V_{OUT}-V_{REF})$	Sum of any offset drift including:			32	mV
V_{Ot}	Long term drift of V_O		12		mV
V_{OT}	Temperature drift of V_O @ $\vartheta_A = -40^\circ C \dots 85^\circ C$		10		mV
$\Delta V_O/\Delta V_C$	Supply voltage rejection ratio		10		mV/V
V_{OH}	Hysteresis of V_{OUT} @ $I_P = 0$ (after an overload of $1000 \times I_{DN}$)		75	125	mV
$V_{OH, Demag}$	Hysteresis after Degaussing			25	mV
V_{OSS}	Offsetripple (without external filter)		70		mV
V_{OSS}	Offsetripple (with 20 kHz-Filter, first order)		20		mV
V_{OSS}	Offsetripple (with 1 kHz-Filter, first order)		6		mV
	Mechanical stress according to M3209/3 Settings: 10-2000Hz, 1min/Octave, 2 hours		1.5		g

Routine Tests:

(Measurement after temperature balance of the samples at room temperature, SC=significant characteristic)

$V_{OUT} (SC)$	(100%) M3011/6:	Output voltage vs. reference	729 ... 751	mV
V_O	(100%) M3226:	Offset voltage ($V_{OUT}-V_{REF}$)	± 25	mV
$V_{OUT}(\text{test current})$	(100%)	Output voltage @ $V_{REF} = 0V$	250 ± 60	mV
U_d	(100%) M3014:	Test voltage, 1s, *acc. table 21	1.8	kV _{RMS}
U_{PDE} $U_{PD} \cdot 1.875$	(AQL 1/S4)	Partial discharge voltage (extinction) *acc. table 24	1.5 1.875	kV _{RMS}

Type Tests:

(Precondition acc. to M3236)

\hat{U}_W	M3064:	Impulse test (1.2 μ s/50 μ s wave form) Pin 1-4 vs. Pin 5-10	6	kV
$\hat{U}_W, \text{prim-prim}$	M3064:	Impulse test (1.2 μ s/50 μ s wave form) Pin 1 vs. Pin 13,14 and Pin 14 vs. Pin 1,2	6	kV
U_d	M3014:	Test voltage, 60s Pin 1-4 vs. Pin 5-10	3.6	kV _{RMS}
$U_d, \text{prim-prim}$	M3014:	Test voltage between primary conductors, 60s Pin 1 vs. Pin 13,14 and Pin 14 vs. Pin 1,2	3.6	kV _{RMS}
U_{PDE} $U_{PD} \cdot 1.875$		Partial discharge voltage (extinction) *acc. table 24	1.5 1.875	kV _{RMS}

* IEC 61800-5-1:2007

Other instructions

- Temperature of the primary conductor should not exceed 105°C.
- Housing and bobbin material UL-listed: Flammability class 94V-0.
- Current direction: A positive output voltage appears at point V_{OUT} , if primary current flows in direction of the arrow.
- Further standards: UL 508, file E317483, category NMTR2 / NMTR8

Hrg.: R&D-PD NPI D
editor

Bearb.: DJ
designer

MC-PM: NSch.
check

freig.: SB
released

K-No.: 26622

300mA Differential Current Sensor for 5V Supply Voltage

For the electronic measurement of current:
DC, AC, pulsed, with galvanic isolation between the primary and the secondary circuit



Date: 28.06.2021

Customer: Standard type

Customers Part no:

Page 4 of 4

Explanation of several terms used in the tables:

V_{Ot} Long term drift of V_O after 100 temperature cycles in the range -40°C to 85°C .

t_r Response time, measured as a delay time at $I_{\Delta P} = 0.9 \cdot I_{\Delta N}$ between a rectangular primary current and the output current or voltage.

t_{ra} Reaction time, measured as a delay time at $I_{\Delta P} = 0.1 \cdot I_{\Delta N}$ between a rectangular primary current and the output current or voltage.

$X_{ges}(I_{\Delta N})$ The sum of all possible errors over the temperature range by measuring a current $I_{\Delta N}$:

$$X_{ges}(I_{\Delta N}) = 100 * \left| \frac{V_{OUT}(I_{\Delta N}) - 2.5V}{0.74V} - 1 \right| \%$$

X Permissible measurement error in the final inspection at RT, defined by

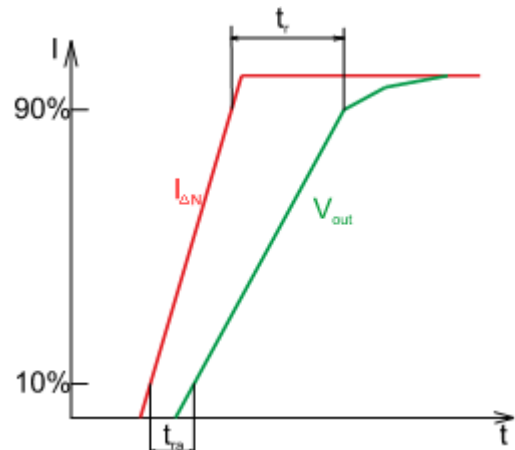
$$X = 100 * \left| \frac{V_{OUT}(I_{\Delta N}) - V_{OUT}(0)}{0.74V} - 1 \right| \%$$

ΔX_{θ} $\Delta X_{\theta} = X_{\theta_{max}} - X_{\theta_{min}}$

ϵ_L Linearity fault defined by: $\epsilon_L = 100 * \left| \frac{I_{\Delta P}}{I_{\Delta N}} - \frac{V_{OUT}(I_{\Delta P}) - V_{OUT}(0)}{V_{OUT}(I_{\Delta N}) - V_{OUT}(0)} \right| \%$

Where $I_{\Delta P}$ is any input DC current and V_{OUT} the corresponding output term. ($V_O = 0$).

RT Room temperature



Application Information

The external test current can be generated with the use of a resistor R and a switch X or something similar (Transistor, Mosfet, etc.). The resistor determine the current at a given voltage and so the output voltage can be calculated.

$$V_{OUT} = V_{REF} \pm \frac{0.74 \cdot \frac{5V}{R + R_{Test}} \cdot 20}{I_{\Delta N}}$$

